## Notice of References Cited Application/Control No. 10/024,412 Examiner Duc M. Nguyen Applicant(s)/Patent Under Reexamination LEUNG ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	А	US-2002/0058501 A1	05-2002	Hannu et al.	455/422
*	В	US-2002/0115407 A1	08-2002	Thompson et al.	455/3.01
*	С	US-6,414,610 B1	07-2002	Smith, Rodney J	341/106
*	D	US-5,951,623 A	09-1999	Reynar et al.	708/203
*	Ε	US-6,883,035 B2	04-2005	Hannu et al.	709/247
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
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	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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